



# Test Report : MHB75-24S12

---

75W DC-DC Half-Brick Regulated Single Output Converter

## ■ DESIGN VERIFY TEST

Output Function Test  
Input Function Test  
Protection Function Test  
Control Function Test

## ■ SAFETY TEST

Safety Test

## ■ RELIABILITY TEST

Other

## DESIGN VERIFY TEST

### OUTPUT FUNCTION TEST

NO	TEST ITEM	SPECICATION	TEST CONDITION	RESULT	VERDICT
1	VOLTAGE ACCURACY	-1%~+1%	I/P:24VDC O/P:100% LOAD Ta:25°C	-0.48%	P
2	RIPPLE & NOISE	100mVp-p	I/P:24VDC O/P:FULL LOAD Ta:25°C	35mV	P
3	LINE REGULATION	-0.2%~+0.2%	I/P:18VDC~36VDC O/P:FULL LOAD Ta:25°C	+0.00% ~ +0.01%	P
4	LOAD REGULATION	-0.2%~+0.2%	I/P:24VDC O/P:MIN-FULL LOAD Ta:25°C	-0.01% ~ +0.01%	P

### INPUT FUNCTION TEST

NO	TEST ITEM	SPECICATION	TEST CONDITION	RESULT	VERDICT
1	INPUT VOLTAGE RANGE	18VDC~36VDC	I/P:TESTING O/P:FULL LOAD Ta:25°C	15.8~36VDC	P
2	EFFICIENCY	88%	I/P:24VDC O/P:FULL LOAD Ta:25°C	89.19%	P
3	DC CURRENT	3650 mA / FULL LOAD 50 mA / NO LOAD	I/P:24VDC O/P:NO / FULL LOAD Ta:25°C	3487 mA / FULL LOAD 11.5 mA / NO LOAD	P

### PROTECTION FUNCTION TEST

NO	TEST ITEM	SPECICATION	TEST CONDITION	RESULT	VERDICT
1	OVER LOAD PROTECTION	110% ~ 150%	I/P:24VDC O/P:TESTING Ta:25°C	128.0% HICCUP MODE AUTO-RECOVER	P
2	OVER VOLTAGE PROTECTION	115% ~ 140%	I/P: TESTING O/P: MIN LOAD Ta:25°C	CLAMP BY ZENER DIODE	P
3	OVER TEMPERATURE PROTECTION	CASE:100 ± 5°C NO DAMAGE	I/P:24VDC O/P: TESTING	96.5°C SHUTDOWN AUTO-RECOVER	P
4	UNDERVOLTAGE LOCKOUT	< 16.0VDC	I/P: TESTING O/P: MIN LOAD Ta:25°C	15.8VDC SHUTDOWN AUTO-RECOVER	P
5	SHORT PROTECTION	SHORT OUTPUT 1 HOUR NO DAMAGE	I/P:36VDC O/P:FULL LOAD Ta:25°C	NO DAMAGE HICCUP MODE AUTO-RECOVER	P

## CONTROL FUNCTION TEST

NO	TEST ITEM	SPECICATION	TEST CONDITION	RESULT	VERDICT
1	REMOTE CONTROL	Power on : R.C ~ -Vin:open Power off : R.C ~ -Vin <0.8Vdc	I/P:24VDC O/P:FULL LOAD Ta:25°C	Power on : R.C>2.1Vdc or Open Power off : R.C<2.0Vdc or Short	P
2	TRIM CONTROL	+10%~ -10% (Typ) Trim ~ +Vout Trim DOWN Trim ~ -Vout Trim UP Using 10k ohm VR	I/P:24VDC O/P:FULL LOAD Ta:25°C	Trim DOWN -10.04% Trim UP +11.93%	P

## SAFETY TEST

### SAFETY TEST

NO	TEST ITEM	SPECICATION	TEST CONDITION	RESULT	VERDICT
1	WITHSTAND VOLTAGE	I/P-O/P:1500 VDC/min I/P-CASE:1500 VDC/min CASE-O/P:1500 VDC/min	I/P-O/P:1500 VDC/min I/P-CASE:1500 VDC/min CASE-O/P:1500 VDC/min Ta:25°C	I/P-O/P: 0.02mA I/P-CASE: 0.02mA CASE-O/P: 0.02mA NO DAMAGE	P
2	ISOLATION RESISTANCE	I/P-O/P:500VDC>100MΩ	I/P-O/P:500 VDC Ta:25°C	I/P-O/P>100MΩ NO DAMAGE	P

## RELIABILITY TEST

### OTHER

NO	TEST ITEM	SPECICATION	TEST CONDITION	RESULT	VERDICT
1	MTBF	MIL-HDBK-217F,GB,25°C TOTAL FAILURE RATE : 1.0 M.T.B.F : 1000 KHRS			P

TEST RESULT	TESTER	APPROVAL
PASS	ARCHEN HSIAO	PETER CHENG